

Notice of References Cited

Application/Control No.

10/562,986

Applicant(s)/Patent Under
Reexamination
HIDAKA ET AL.

Examiner

John P. Sheehan

Art Unit

1793

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0188267 A1	09-2004	Sakamoto et al.	205/181
*	B	US-2003/0172995 A1	09-2003	Makita et al.	148/101
*	C	US-6,254,694 B1	07-2001	Hasegawa et al.	148/101
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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